Search Notes



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10/810,895 Examiner

Huan H. Tran

Applicant(s)/Patent under Reexamination

TANAKA ET AL.

Art Unit

2861

SEARCHED					
Class	Subclass	Date	Examiner		
347	116	2/10/2006	ннт		
399	301	2/10/2006	ННТ		
					
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INTERFERENCE SEARCHED				
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Interference search_see search history printout		6/15/2006	ннт	

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
EAST text search (USPAT;US_PGPUB;JPO;EPO;DER WENT;IBM_TDB)-see search history printout	2/10/2006	ННТ		
text search updated	6/15/2006	ннт		